## **EAST Search History**

## **EAST Search History (Prior Art)**

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L50	25	(test with (circuit apparatus)) and ((compar\$4 difference) with test with reference with (signal input waveform)) and (phase with reference with (match match\$3) with test with (signal input waveform))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 22:37
L51	2	(test with (circuit apparatus) with test with (signal input waveform)) and (reference with (circuit apparatus) with test with (signal input waveform)) and ((compar\$4 difference) with test with reference with (signal input waveform)) and (phase with reference with (match match\$3) with test with (signal input waveform))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 22:38

L52	73	(test with (circuit apparatus) with test with (signal input waveform)) and (reference with (circuit apparatus) with test with (signal input waveform)) and ((compar\$4 difference) with test with reference with (signal input waveform)) and (phase with reference with (match match\$3 synchroniz\$5) with test with (signal input waveform))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 22:53
L53	51	52 not(51)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 22:53
L54	16	(test with (circuit apparatus) with (ic (integrated with circuit))) and (reference with (circuit apparatus) with test with (signal input waveform)) and ((compar\$4 difference) with test with reference with (signal input waveform)) and (phase with reference with (match match\$3 synchroniz\$5) with test with (signal input waveform))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 23:04

L55	32	(test with (circuit apparatus) with (ic (integrated with circuit) dut (device with under with test))) and (reference with (circuit apparatus) with test with (signal input waveform)) and ((compar\$4 difference) with test with reference with (signal input waveform)) and (phase with reference with (match match\$3 synchroniz\$5) with test with (signal input waveform))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 23:11
L56	32	(test with (circuit apparatus) with (ic (integrated with circuit) dut (device with under with test)) ) and (reference with (circuit apparatus) with test with (signal input waveform)) and ((compar\$4 difference) with test with reference with (signal input waveform)) and (phase with reference with (match match\$3 synchroniz\$5) with test with (signal input waveform)) and (journel of the synchroniz\$5) with test with (signal input waveform)) and ((ic (integrated))) and ((ic (integrated)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 23:11

		with circuit) dut (device with under with test)) with test with (signal input waveform))				
L57	29	(test with (circuit apparatus) with (ic (integrated with circuit) dut (device with under with test)) and (reference with (circuit apparatus) with test with (signal input waveform)) and ((compar\$4 difference) with test with reference with (signal input waveform)) and (phase with reference with (match match\$3 synchroniz\$5) with test with (signal input waveform)) and ((ic (integrated with circuit) dut (device with under with test)) with test with (signal input waveform)) and ((ic (integrated with circuit) dut (device with under with test)) with reference with (signal input waveform)) and ((ic (integrated with circuit) dut (device with under with test)) with reference with (signal input waveform)) with reference with (signal input waveform))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2010/07/19 23:12

L58	16	55 not(54)	US-PGPUB; OF	R ON	2010/07/19
			USPAT;		23:12
	i		USOCR; FPRS;		
			EPO; JPO;		
			DERWENT;		
			IBM_TDB		

## 7/19/10 11:22:56 PM

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